





EH35 25

Series —
RoHS Compliant (Pb-free) 5.0V 4 Pad 3.2mm x 5mm
Ceramic SMD HCMOS/TTL High Frequency Oscillator

Frequency Tolerance/Stability — ±25ppm Maximum

Operating Temperature Range — 0°C to +70°C

TS -14.31818M

Nominal Frequency 14.31818MHz

- Pin 1 Connection Tri-State (Disabled Output: High Impedance)

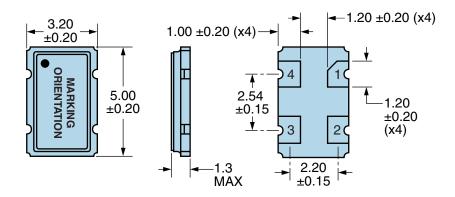
Duty Cycle 50 ±5(%)

Frequency Tolerance/Stability  ±25p Oper Shoot Aging at 25°C  ±5pp Operating Temperature Range  5.0V Output Voltage Output Voltage Logic High (Voh) Output Voltage Logic Low (Vol)  Rise/Fall Time  £25p Oper \$425p Over \$42	.31818MHz	
Aging at 25°C ±5pp Operating Temperature Range 0°C Supply Voltage 5.0V Output Voltage Logic High (Voh) 2.4V Output Voltage Logic Low (Vol) 0.4V Rise/Fall Time 6nSe	5 M 1 (1 L 1 C II III O III C T L 10500 5	
Operating Temperature Range 0°C Supply Voltage 5.0V supply Voltage 5.0V output Current 50m. Output Voltage Logic High (Voh) 2.4V Output Voltage Logic Low (Vol) 0.4V Rise/Fall Time 6nSe	±25ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, 1st Year Aging at 25°C, Shock, and Vibration)	
Supply Voltage 5.0V  nput Current 50m.  Dutput Voltage Logic High (Voh) 2.4V  Dutput Voltage Logic Low (Vol) 0.4V  Rise/Fall Time 6nSe	ppm/year Maximum	
nput Current 50m.  Dutput Voltage Logic High (Voh) 2.4V  Dutput Voltage Logic Low (Vol) 0.4V  Rise/Fall Time 6nSe	0°C to +70°C	
Output Voltage Logic High (Voh) 2.4V Output Voltage Logic Low (Vol) 0.4V Rise/Fall Time 6nSe	0Vdc ±10%	
Output Voltage Logic Low (Vol) 0.4V Rise/Fall Time 6nSe	mA Maximum (No Load)	
Rise/Fall Time 6nSe	Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH = -16mA)	
	Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOL = +16mA)	
HCIV	Sec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load or at 20% to 80% of waveform with CMOS Load)	
Outy Cycle 50 ±	±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)	
Load Drive Capability 10T7	TTL Load or 50pF HCMOS Load Maximum	
Output Logic Type CMC	nos	
Pin 1 Connection Tri-S	-State (Disabled Output: High Impedance)	
	.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to able output.	
Absolute Clock Jitter ±250	50pSec Maximum, ±100pSec Typical	
One Sigma Clock Period Jitter ±50p	0pSec Maximum, ±30pSec Typical	
Start Up Time 10m	-O. Mariana	
Storage Temperature Range -55°0	mSec Maximum	

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
Fine Leak Test MIL-STD-883, Method 1014, Condition A		
Gross Leak Test	MIL-STD-883, Method 1014, Condition C	
Mechanical Shock	MIL-STD-202, Method 213, Condition C	
Resistance to Soldering Heat	MIL-STD-202, Method 210	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, MEthod 1010	
Vibration	MIL-STD-883, Method 2007, Condition A	



## **MECHANICAL DIMENSIONS (all dimensions in millimeters)**

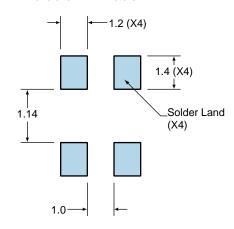


PIN CONNECTION	
1	Tri-State
2	Ground/Case Ground
3	Output
4	Supply Voltage

LINE	MARKING
1	E14.318 E=Ecliptek Designator

### **Suggested Solder Pad Layout**

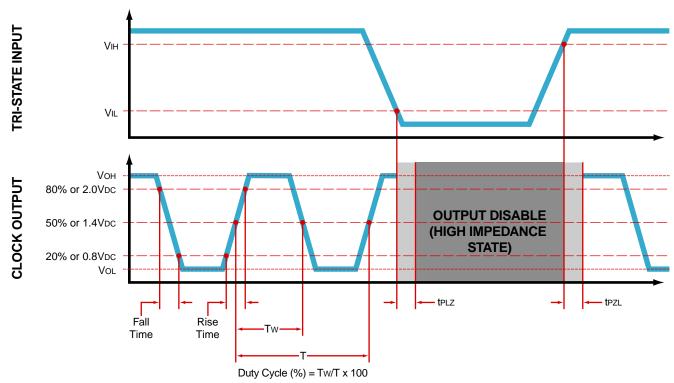
All Dimensions in Millimeters



All Tolerances are ±0.1



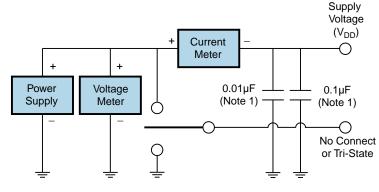
#### **OUTPUT WAVEFORM & TIMING DIAGRAM**

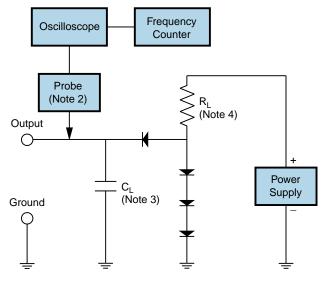


#### **Test Circuit for TTL Output**

Output Load Drive Capability	R <sub>L</sub> Value (Ohms)	C <sub>L</sub> Value (pF)
10TTL	390	15
5TTL	780	15
2TTL	1100	6
10LSTTL	2000	15
1TTL	2200	3

Table 1:  $R_L$  Resistance Value and  $C_L$  Capacitance Value Vs. Output Load Drive Capability





Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $C_{\mathsf{L}}$  includes sum of all probe and fixture capacitance.

Note 4: Resistance value R<sub>L</sub> is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.

Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



### **Test Circuit for CMOS Output**



Note 1: An external  $0.1\mu\text{F}$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu\text{F}$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_L$  includes sum of all probe and fixture capacitance.



# **Recommended Solder Reflow Methods**



## **High Temperature Infrared/Convection**

T <sub>s</sub> MAX to T <sub>∟</sub> (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (Ts MIN)	150°C
- Temperature Typical (T <sub>s</sub> TYP)	175°C
- Temperature Maximum (T <sub>s</sub> MAX)	200°C
- Time (t <sub>s</sub> MIN)	60 - 180 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T <sub>P</sub> Target)	250°C +0/-5°C
Time within 5°C of actual peak (tp)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1



## **Recommended Solder Reflow Methods**



### Low Temperature Infrared/Convection 240°C

T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	N/A
- Temperature Typical (T <sub>s</sub> TYP)	150°C
- Temperature Maximum (T <sub>s</sub> MAX)	N/A
- Time (t <sub>s</sub> MIN)	60 - 120 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C/second Maximum
Time Maintained Above:	
- Temperature (T <sub>L</sub> )	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T <sub>P</sub> )	240°C Maximum
Target Peak Temperature (T <sub>P</sub> Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (tp)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

### **Low Temperature Manual Soldering**

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.